#### TOSHIBA CMOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

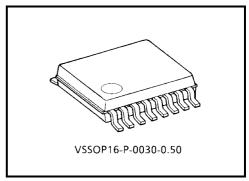
# TC7MTX01FK

#### Digital temperature compensation IC

Due to the demand for compactness and lower power dissipation, circuits for portable devices are being manufactured as individual chips. In particular, during the manufacture of modular devices comprised of several individual discrete devices, significant time and effort must be devoted to adjusting the temperature characteristic of each discrete device individually, In addition, the demand for low power consumption is increasing.

In response to these requirements, Toshiba have developed the TC7MTX01FX, a digital temperature compensation IC.

To shiba have implemented this device completely in CMOS, obviating the need to use combinations of individual electronic components, such as thermistors and resistors, as was the case previously. The new digital temperature compensation IC incorporates a temperature sensor, an  $E^2PROM$  and a DA converter. The IC is accurate to within  $\pm 4^{\circ}C.$ 



Weight: 0.02 g (typ.)

To meet the demand for compactness, the IC comes in the World's smallest and flattest 16-pin package (US16).

#### **Features**

- Temperature compensation precision: ±4°C (in the range -20~70°C)
- Analog output (XOcont):

Outputs an analog voltage whose level corresponds to 1°C increments in the above temperature range.

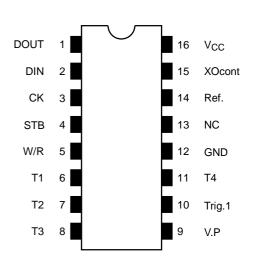
Control resolution: 10.98 mV (typ.)/Bit

Linearity: ±1LSB

Output response speed: 500 µs

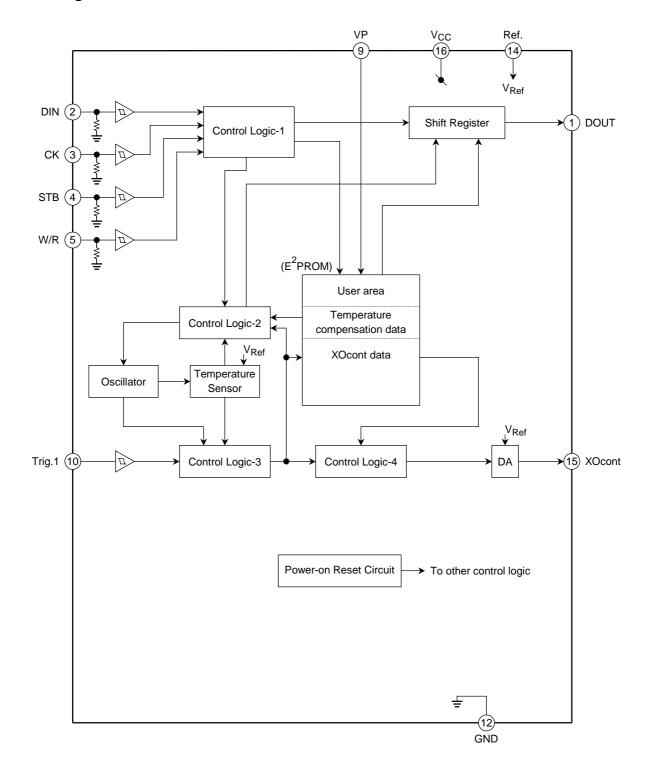
- Supply voltage operating range: 2.7~3.3 V
- Built-in E<sup>2</sup>PROM: Write voltage 17 V (min)~19 V (max): Write time: 10 ms
- Reference voltage (V<sub>Ref</sub>): 2.8 V (typ.)
- Current dissipation: 1.0 mA (max) @25°C
- ESD:  $\pm 2000$  V or more (MIL-STD method)
- Latch-up: ±200 mA or more

#### Pin Layout (top view)



Note: All pins (T1~T4) must be connected to the V<sub>CC</sub> or the GND.

### **Block Diagram**



Pins 2~5 incorporate pull-down resistors (R  $\simeq$  10 k $\Omega$ )

#### **Description of Operation**

## Operation of E<sup>2</sup>PROM read/write OP codes

The operations listed below in the Operation mode selection table are performed using the five pins V.P, W/R, STB, CK and DIN.

All operations modes other than Normal Operation Mode are triggered by 8-bit serial data input on DIN and CK on the rising edge of STB. The operation mode is determined by the combination of the W/R signal and the OP code.

Operation mode selection table

No.	Operating Mode	STB	W/R	V.P	Serial input on DIN (CK)							
NO.	Operating infode	SID	VV/IX	V.1	DI1	DI2	DI3	DI4	DI5	DI6	DI7	DI8
1	E <sup>2</sup> PROM write mode	Н	Н	18 V	Н	A6	A5	A4	А3	A2	A1	A0
2	E <sup>2</sup> PROM read mode	Н	L	_	Н	A6	A5	A4	А3	A2	A1	A0
3	E <sup>2</sup> PROM All-erase mode	Н	Н	18 V	L	Н	L	L	L	*	*	*
4	E <sup>2</sup> PROM All-write overwrite mode	Н	Н	18 V	L	Н	L	L	Н	*	*	*
5	Temperature data read mode (before compensation: ADC output)	Н	L	_	L	Н	L	Н	L	*	*	*
6	Temperature data read mode (after compensation: register output)	Н	L		L	Н	L	Н	Н	*	*	*
7	Normal operation mode	L	L		*	*	*	*	*	*	*	*

—: NC or V<sub>CC</sub>, \*: Don't care, A6~A0: specify address of E<sup>2</sup>PROM word

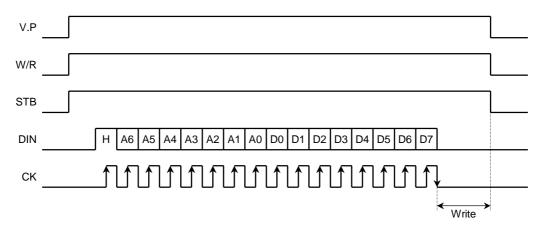
# 1. $E^2$ PROM Write Mode (V.P = 18 V, W/R = "H", DI1 = "H")

Input of an OP code (DI1 = H, A6 $\sim$ A0 = address of word to be written) on DIN (while 18 V is applied to V.P, W/R = H and STB = H) writes data D0 $\sim$ D7 to the E<sup>2</sup>PROM at the timing shown below.

Note that if D0~D7 are all High, a Byte Erase (all bits are set to H) is performed.

The write starts on the falling edge of the 16<sup>th</sup> CK pulse and ends when STB goes Low.

During a write, DOUT is High-Impedance.

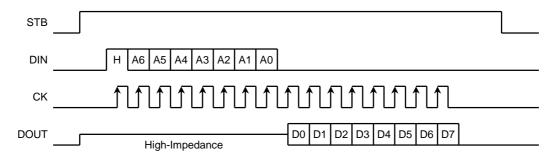


**Data Write Mode timing chart** 

### 2. $E^2$ PROM Read Mode (W/R = "L", DI1 = "H")

Input of an OP code (DI1 = H, A6 $\sim$ A0 = address of word to be read) on DIN (while W/R = L and STB = H) reads data D0 $\sim$ D7 from the E<sup>2</sup>PROM to DOUT.

The read ends when STB goes Low.

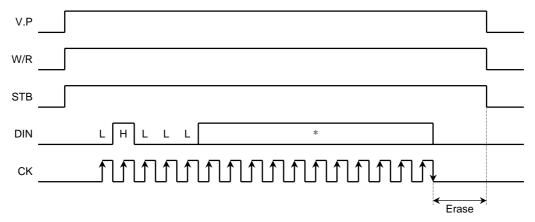


#### **Data Read Mode timing chart**

### 3. E<sup>2</sup>PROM All-erase Mode

Input of an OP code (DI1 = L, DI2 = H, DI3 = L, DI4 = L, DI5 = L) to DIN (while 18 V is applied to V.P, W/R = H and STB = H) proceeds to erase all data in the E2PROM (all bits are set to H), starting on the falling edge of the 16th CK pulse and continuing until STB goes Low.

During Erase Mode, DOUT is High-Impedance.



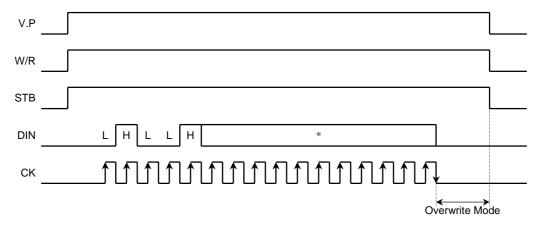
E<sup>2</sup>PROM Erase Mode timing chart

\*: Don't care

### 4. E<sup>2</sup>PROM All-write Mode

Input of an OP code (DI1 = L, DI2 = H, DI3 = L, DI4 = L, DI5 = H) on DIN (while 18 V is applied to V.P, W/R = H and STB = H) proceeds to overwrite the entire  $E^2PROM$  (all bits are set to L), starting on the falling edge of the  $16^{th}$  CK pulse and continuing until STB goes Low.

During Overwrite Mode, DOUT is High-Impedance.



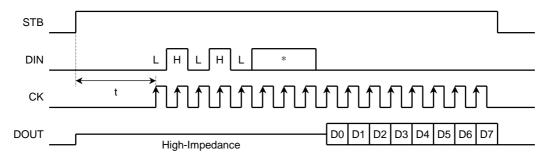
E<sup>2</sup>PROM All-write timing chart

\*: Don't care

# 5. Temperature Data Read Mode (before compensation: temperature sensor output) (W/R = "L", DI1 = "L", DI2 = "H", DI3 = "L", DI4 = "H", DI5 = "L")

Input of an OP code (DI1 = L, DI2 = H, DI3 = L, DI4 = H, DI5 = L) on DIN converts the analog data from the temperature sensor to 8-bit digital data and outputs it on DOUT.

The read ends when STB goes Low.



Timing chart for Temperature Data Read Mode (pre-compensation)

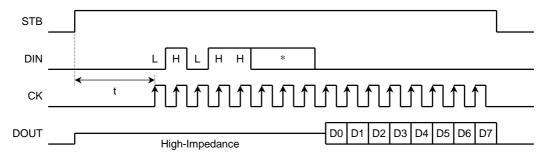
\*: Don't care

Note 1: The temperature sensor is triggered on the rising edge of STB. Allow a period of length t to elapse so that operation can stabilize.

# 6. Temperature Data Read Mode (after compensation: register output) (W/R = "L", DI1 = "L", DI2 = "H", DI3 = "L", DI4 = "H", DI5 = "H")

Input of an OP code (DI1 = L, DI2 = H, DI3 = L, DI4 = H, DI5 = H) on DIN outputs an 8-bit address on DOUT corresponding to the current temperature (sum of 8-bit temperature sensor output and  $25^{\circ}$ C temperature compensation data sensor stored at  $E^{2}$ PROM address 0FH).

The read ends when STB goes Low.



\*: Don't care Timing chart for Temperature Data Read Mode (post-compensation)

Note 1: The temperature sensor is triggered on the rising edge of STB. Allow a period of length t to elapse so that operation can stabilize.

#### 7. Normal Operation Mode (STB = "L")

While STB = L, all inputs on W/R, CK and DIN are invalid and the IC is in Normal Operation Mode (this is referred to as XOcont Output Control state).

During Normal Operation Mode, the DOUT output level reflects the power-on reset status.

(Output level is High during power-on reset and Low after release of power-on reset.)



# E<sup>2</sup>PROM Contents

The  $E^2$ PROM is organized as 8 bits x 124 words (= 992 bits) and its contents is as shown below.

E<sup>2</sup>PROM Data Save Map

Word	BIT	Word	BIT	Word	BIT
(HEX)	0 1 2 3 4 5 6 7	(HEX)	0 1 2 3 4 5 6 7	(HEX)	0 1 2 3 4 5 6 7
00	Reserved for users		XOcont (10°C)		XOcont (58°C)
00	As above	30 31	XOcont (10°C)	60 61	XOcont (59°C)
02	As above As above	32	XOcont (12°C)	62	XOcont (60°C)
03			` '		` '
03	As above	33 34	XOcont (13°C) XOcont (14°C)	63 64	XOcont (61°C) XOcont (62°C)
05	As above As above	35	XOcont (15°C)	65	XOcont (63°C)
06	As above As above	36	XOcont (16°C)	66	XOcont (64°C)
07	As above As above	37	XOcont (17°C)	67	XOcont (65°C)
08	As above As above	38	XOcont (18°C)	68	XOcont (65°C)
09	As above	39	XOcont (19°C)	69	XOcont (67°C)
09 0A	As above As above	3A	XOcont (19°C)	6A	XOcont (68°C)
0B	As above	3B	XOcont (21°C)	6B	XOcont (69°C)
OC	As above	3C	XOcont (22°C)	6C	XOcont (70°C)
0D	As above As above	3D	XOcont (23°C)	6D	XOcont (70°C)
0E	As above As above	3E	XOcont (24°C)	6E	XOcont (71°C)
	25°C temperature sensor		` ′		` '
0F	compensation data	3F	XOcont (25°C)	6F	XOcont (73°C)
10	XOcont (-22°C)	40	XOcont (26°C)	70	Reserved for users
11	XOcont (-21°C)	41	XOcont (27°C)	71	As above
12	XOcont (-20°C)	42	XOcont (28°C)	72	As above
13	XOcont (-19°C)	43	XOcont (29°C)	73	As above
14	XOcont (-18°C)	44	XOcont (30°C)	74	As above
15	XOcont (-17°C)	45	XOcont (31°C)	75	As above
16	XOcont (-16°C)	46	XOcont (32°C)	76	As above
17	XOcont (-15°C)	47	XOcont (33°C)	77	As above
18	XOcont (-14°C)	48	XOcont (34°C)	78	As above
19	XOcont (-13°C)	49	XOcont (35°C)	79	As above
1A	XOcont (-12°C)	4A	XOcont (36°C)	7A	As above
1B	XOcont (-11°C)	4B	XOcont (37°C)	7B	As above
1C	XOcont (-10°C)	4C	XOcont (38°C)		
1D	XOcont (-9°C)	4D	XOcont (39°C)		
1E	XOcont (-8°C)	4E	XOcont (40°C)		
1F	XOcont (-7°C)	4F	XOcont (41°C)		
20	XOcont (-6°C)	50	XOcont (42°C)		
21	XOcont (-5°C)	51	XOcont (43°C)		
22	XOcont (-4°C)	52	XOcont (44°C)		
23	XOcont (-3°C)	53	XOcont (45°C)		
24	XOcont (-2°C)	54	XOcont (46°C)		
25	XOcont (-1°C)	55	XOcont (47°C)		
26	XOcont (0°C)	56	XOcont (48°C)		
27	XOcont (1°C)	57	XOcont (49°C)		
28	XOcont (2°C)	58	XOcont (50°C)		
29	XOcont (3°C)	59	XOcont (51°C)		
2A	XOcont (4°C)	5A	XOcont (52°C)		
2B	XOcont (5°C)	5B	XOcont (53°C)		
2C	XOcont (6°C)	5C	XOcont (54°C)		
2D	XOcont (7°C)	5D	XOcont (55°C)		
2E	XOcont (8°C)	5E	XOcont (56°C)		
2F	XOcont (9°C)	5F	XOcont (57°C)		

(Contents of addresses 00H~0EH): Reserved area for users

(Contents of address 0FH): 25°C temperature sensor compensation data (8-bit data is used to compensate for temperature fluctuation in sensor ICs.)

(Contents of addresses 10H $\sim$ 6FH): XOcont temperature data (temperature range:  $-22^{\circ}$ C $\sim$ 73 $^{\circ}$ C, 8-bit data, one value for each 1 $^{\circ}$ C increment)

(Contents of addresses 70H~7BH): Reserved

#### **XOcont Output Operation**

XOcont is the output pin used to output temperature compensation data (XOcont data) corresponding to the output from the built-in temperature sensor. Data corresponding to each 1°C temperature increment is stored in the E<sup>2</sup>PROM.

#### 1. Output at power-on

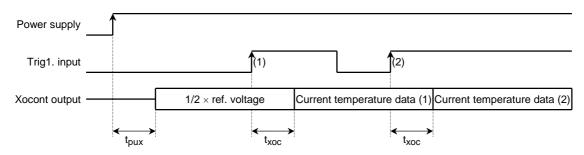
At power-on, 1/2 x ref. voltage (80H) is output on XOcont.

Delay time tpux, from power-on to start of output of 1/2 x ref. voltage, is 100 µs or less.

#### 2. Output caused by trigger input

The rising edge of the Trig.1 input triggers the built-in temperature sensor. The sum of the temperature sensor output and  $25^{\circ}$ C temperature sensor compensation data (stored at address 0FH) is used as the XOcont data address. The XOcont data is converted to an analog voltage level and output on XOcont.

The delay time txoc, from Trig.1 input to start of voltage output, is 500 µs or less.



**Output timing for XOcont** 

#### 3. XOcont data

The XOcont data is stored at addresses  $10H\sim6FH$  of the E<sup>2</sup>PROM and is used as compensation data corresponding to every 1°C increment in the ambient temperature range -22°C $\sim73$ °C.

The voltage output on XOcont corresponds to the 8-bit data stored in the  $E^2PROM$  (0 V for the value stored at address 00H;  $V_{Ref}$  for the value stored at address FFH).

When the ambient temperature is outside the range of the  $E^2PROM$  table (i.e. below  $-22^{\circ}C$  or above  $73^{\circ}C$ ), the compensation value for the table's minimum or maximum temperature ( $-22^{\circ}C$  or  $73^{\circ}C$ ) is output.

#### **Temperature Sensor**

The IC incorporates a temperature sensor which can detect temperatures with an accuracy of  $1^{\circ}$ C. The sum of the output from the temperature sensor (after conversion to a digital value) and the  $25^{\circ}$ C temperature sensor compensation data (stored at address 0FH) is used as the E²PROM address of the compensation data.

In Normal Operation Mode, the temperature sensor is inactive. The sensor is triggered by the rising edge of STB or by the Trig.1 input. On completion of operation, the sensor returns to its inactive state.

The 25°C temperature sensor compensation data can be written to address 0FH of the E2PROM as follows:

#### Measurement of ambient temperature and device temperature data (before compensation)

- The ambient temperature of the test environment is measured.
- Read the temperature data of TC7MTX01FK before compensation

#### 2. Calculation of 25°C temperature sensor compensation data

- If the ambient temperature is 25°C, the compensation data can be calculated as follows: 25°C temperature sensor compensation data = 3FH temperature data before compensation
- If the ambient temperature is not 25°C, add the difference between the ambient temperature and 25°C to the result of the above calculation.

The following table shows  $25^{\circ}$ C temperature sensor compensation values corresponding to the ambient temperature and the raw temperature data

25°C temperature sensor compensation values corresponding to the ambient temperature and the temperature data before compensation

Towardure Data											
Temperature Data before Compensation			Am	bient Tempe	erature in Te	st Environm	ent				
(TC7MTX01FK)	21°C	22°C	23°C	24°C	25°C	26°C	27°C	28°C	29°C		
82		BA	BB	ВС	BD	BE	BF	C0	C1		
81	BA	BB	BC	BD	BE	BF	C0	C1	C2		
80	BB	ВС	BD	BE	BF	C0	C1	C2	C3		
7F	ВС	BD	BE	BF	C0	C1	C2	C3	C4		
7E	BD	BE	BF	C0	C1	C2	C3	C4	C5		
7D	BE	BF	C0	C1	C2	C3	C4	C5	C6		
7C	BF	C0	C1	C2	C3	C4	C5	C6	C7		
7B	C0	C1	C2	C3	C4	C5	C6	C7	C8		
7A	C1	C2	C3	C4	C5	C6	C7	C8	C9		
79	C2	C3	C4	C5	C6	C7	C8	C9	CA		
78	C3	C4	C5	C6	C7	C8	C9	CA	СВ		
77	C4	C5	C6	C7	C8	C9	CA	СВ	CC		
76	C5	C6	C7	C8	C9	CA	СВ	CC	CD		
75	C6	C7	C8	C9	CA	СВ	CC	CD	CE		
74	C7	C8	C9	CA	СВ	CC	CD	CE	CF		
73	C8	C9	CA	СВ	CC	CD	CE	CF	D0		
72	C9	CA	СВ	CC	CD	CE	CF	D0	D1		
71	CA	СВ	CC	CD	CE	CF	D0	D1	D2		
70	СВ	CC	CD	CE	CF	D0	D1	D2	D3		
6F	CC	CD	CE	CF	D0	D1	D2	D3	D4		
6E	CD	CE	CF	D0	D1	D2	D3	D4	D5		
6D	CE	CF	D0	D1	D2	D3	D4	D5	D6		
6C	CF	D0	D1	D2	D3	D4	D5	D6	D7		
6B	D0	D1	D2	D3	D4	D5	D6	D7	D8		
6A	D1	D2	D3	D4	D5	D6	D7	D8	D9		
69	D2	D3	D4	D5	D6	D7	D8	D9			

All values above are hexadecimal.

## 3. E<sup>2</sup>PROM Write

This instruction writes the  $25^{\circ}$ C address compensation data to address 0FH in the  $E^{2}$ PROM.

# **Maximum Ratings (GND = 0.0 V)**

Characteristic	Symbol	Rating	Unit	Pin
Supply voltage	$V_{CC}$	-0.5~4.6	V	Vcc
E <sup>2</sup> PROM write voltage	V <sub>P</sub>	-0.5~20.0	V	V.P
Reference voltage	V <sub>Ref</sub>	-0.5~V <sub>CC</sub> + 0.5	V	Ref.
Input voltage	V <sub>IN</sub>	-0.5~4.0	V	DIN, CK, STB, W/R, Trig1
Output voltage	V <sub>OUT</sub>	-0.5~V <sub>CC</sub> + 0.5	V	DOUT, XOcont
Input current	I <sub>IN</sub>	±10	mA	DIN, CK, STB, W/R, Trig1
Power dissipation	P <sub>D</sub>	180	mW	
Storage temperature	T <sub>stg</sub>	-40~125	°C	

# Recommended Operating Conditions (GND = 0.0 V)

Characteristic	Symbol	Min	Тур.	Max	Unit
Supply voltage	V <sub>CC</sub>	2.7	3.0	3.3	V
E <sup>2</sup> PROM write voltage	V <sub>P</sub>	17.0	18.0	19.0	V
Reference voltage	V <sub>Ref</sub>	2.7	2.8	2.9	V
Input voltage	V <sub>IN</sub>	0	_	$V_{CC}$	V
Input rise/fall time	$t_{r\varphi},t_{f\varphi}$	_	_	1.0	μS
Power-on rise time	t <sub>V</sub>	100	_	_	μS
Operating temperature	T <sub>opr</sub>	-22		73	°C

# E<sup>2</sup>PROM Characteristics

Characteristic	Symbol	Test Circuit	Min	Тур.	Max	Unit
No. of rewrites	N <sub>wr</sub>	$Ta = 25$ °C, $V_{CC} = 3.0 \text{ V}$ , $V_P = 18.0 \text{ V}$	10000	_	_	Times
Data retention time	t <sub>RET</sub>	Ta = -22~73°C	10	_	_	Years

### DC Characteristics (GND = 0.0 V)

Characteristic	Symbol	Test Circuit	Ta = -	-20°C	-	Ta = 25°0	)	Ta =	70°C	Unit
Characteristic	Symbol	rest Circuit	Min	Max	Min	Тур.	Min	Min	Max	Offic
High-level input voltage	V <sub>IH</sub>	V <sub>CC</sub> = 2.7~3.3 V	2.0	_	2.0	_	_	2.0	_	V
Low-level input voltage	V <sub>IL</sub>	V <sub>CC</sub> = 2.7~3.3 V	_	0.5	_	_	0.5	_	0.5	V
Hysteresis voltage	V <sub>H</sub>	V <sub>CC</sub> = 3.0V	_	_	_	0.3	_	_	_	V
High-level output current (DOUT)	I <sub>OH</sub>	V <sub>CC</sub> = 3.0 V V <sub>OH</sub> = 2.4 V	4.0	_	4.0	7.0	_	3.2	_	mA
Low-level output current (DOUT)	loL	V <sub>CC</sub> = 3.0 V V <sub>OL</sub> = 0.4 V	4.0	_	4.0	8.5	—	3.2	_	mA
Input current	I <sub>IN</sub>	V <sub>CC</sub> = 3.3 V V <sub>IN</sub> = 0 or 3.3 V	_	±1.0	_	_	±1.0	_	±5.0	μА
Three-state OFF leakage current (DOUT)	l <sub>OZ</sub>	V <sub>CC</sub> = 3.3 V V <sub>OUT</sub> = 0 or 3.3 V		±1.0			±1.0		±5.0	μА
Pull-down resistance (DIN, CK, STB, W/R)	R <sub>PD</sub>	V <sub>CC</sub> = 2.7~3.3 V	_	_	4	10	20	_	_	kΩ
Auto-reset release voltage	$V_{RD}$		_	2.5	_	1.8	2.5	_	2.5	V
Static current dissipation	Icc	$V_{CC} = 3.0 \text{ V (Note 2)}$ $V_{IN} = V_{CC} \text{ or GND}$	_	_	_	0.5	1.0	—	_	mA
Static current dissipation	I <sub>REF</sub>	$V_{CC} = 2.8 \text{ V}$ (Note2) $V_{IN} = V_{CC} \text{ or GND}$		_	_	0.1	1.0	_	_	mA

Note2: The current generated by setting the input pins with pull-down resistors to High is not included.

#### **AC Characteristics**

 $(Ta = 25^{\circ}C, V_{CC} = 3.0 \text{ V}, V_{Ref} = 2.8 \text{ V}, GND = 0 \text{ V}, C_{L} = 50 \text{ pF}, Input: } t_r, t_f = 6 \text{ ns})$ 

# E<sup>2</sup>PROM Write Timing (applies to Operation Modes 1, 3 and 4)

Characteristic	Symbol	Test Circuit	Тур	Limit	Unit
Minimum VP power-on timing time (V.P power supply – STB input)	t <sub>sv</sub>	Figure 1	_	0	ns
Minimum VP power-off timing time (STB input – V.P power supply)	t <sub>hv</sub>	Figure 1	_	0	ns
Minimum VP power supply cut-off pulse width	t <sub>wL</sub>	Figure 1	_	10	μS
Minimum set-up time (W/R input – STB input)	t <sub>sw</sub>	Figure 1	_	0	ns
Minimum hold time (W/R input – STB input)	t <sub>hw</sub>	Figure 1	_	40	ns
Minimum removal time (STB input – CK input)	t <sub>rem</sub>	Figure 1	-5	40	ns
Minimum write time (CK input – W/R input)	t <sub>pws</sub>	Figure 1	_	10	ms
Minimum pulse width (STB input)	t <sub>wL</sub>	Figure 1	_	10	μS
Minimum clock cycle time (CK input)	t <sub>cyc</sub>	Figure 1	0.2	2	μS
Minimum clock pulse width (CK input)	t <sub>wH</sub> t <sub>wL</sub>	Figure 1	0.1	1	μS
Minimum set-up time (DIN input – CK input)	t <sub>su</sub>	Figure 1	-3	40	ns
Minimum hold time (DIN input – CK input)	t <sub>h</sub>	Figure 1	5	40	ns



# E<sup>2</sup>PROM Read Timing (applies to Operation Mode 2)

Characteristic	Symbol	Test Circuit	Тур	Limit	Unit
Minimum set-up time (W/R input – STB input)	t <sub>sr</sub>	Figure 2	_	0	ns
Minimum hold time (W/R input – STB input)	t <sub>hr</sub>	Figure 2	_	0	ns
Minimum removal time (STB input – CK input)	t <sub>rem</sub>	Figure 2	-5	40	ns
Minimum pulse width (STB input)	t <sub>wL</sub>	Figure 2	0.1	1	μS
Minimum clock cycle time (CK input)	t <sub>cyc</sub>	Figure 2	0.2	2	μS
Minimum clock pulse width (CK input)	t <sub>wH</sub> t <sub>wL</sub>	Figure 2	0.1	1	μS
Minimum set-up time (DIN input – CK input)	t <sub>su</sub>	Figure 2	-3	40	ns
Minimum hold time (DIN input – CK input)	t <sub>h</sub>	Figure 2	5	40	ns
Propagation delay time (CK input – DOUT output)	t <sub>pZH</sub> t <sub>pZL</sub>	On first DOUT output Figure 2	15	100	ns
Propagation delay time (CK input – DOUT output)	t <sub>pLH</sub> t <sub>pHL</sub>	On second and subsequent DOUT outputs Figure 2	15	100	ns
Output Disable time (STB input – DOUT output)	t <sub>PLZ</sub> t <sub>pHL</sub>	Figure 2	20	100	ns

#### Timing in Other Modes (applies to Operation Modes 5 and 6)

Characteristic	Symbol	Test Circuit	Тур	Limit	Unit
Minimum removal time (STB input – CK input)	t <sub>rem</sub>	Operation modes 5 and 6 (temperature data read modes) Figure 2	140	400	μS

Note3: All characteristics except for  $t_{\text{rem}}$  are the same as those for the  $\text{E}^2\text{PROM}$  read timing.

# Characteristics of Analog Block (Ta = 25°C, $V_{CC}$ = 2.80 V, $V_{Ref}$ = 2.80 V, GND = 0 V)

### **XOcont Output**

Characteristic	Symbol	nbol Test Circuit -		Га = 25°C		Ta = -2	Unit	
Characteristic	Characteristic		Min	Тур.	Max	Min	Max	Offic
XOcont output response time (Trig.1 – XOcont)	t <sub>xoc</sub>	Figure 3	_	200	450	_	500	μS
XOcont output voltage	V <sub>XOC</sub>	XOcont data: 80H XOcont output < 1 μA	1380	1400	1420	1380	1420	mV
XOcont output voltage variation	ΔV <sub>XOC</sub>	XOcont data1 per bit XOcont output < 1 μA	_	10.98	_	_		mV
XOcont output voltage linearity	ΔNLX	XOcont data: 00H ≤ DATA ≤ FFH (Note 4)		±0.5	±1	_	±1	LSB

#### **Temperature Sensor**

Characteristic	Symbol	Test Circuit		Min	Тур.	Max	Unit
Temperature sensor output Value (output at Ta = 25°C before compensation)	Tsen1	Ta = 25°C Temperature sensor output before compensation		60H	74H	88H	
Temperature sensor output Value (output at Ta = -22°C before compensation)	Tsen2	Ta = -22°C Temperature sensor output before compensation		31H	45H	59H	_
Temperature sensor output Value (output at Ta = 72°C before compensation)	Tsen3	Ta = 73°C Temperature sensor output before compensation		90H	A4H	В8Н	_
Temperature sensor output Variation	ΔTS	Per 1°C		_	1	_	LSB
Temperature sensor output Linearity	ΔNLT	-22°C ≦ Ta ≦ 73°C (I	Note4)	_	±0.5	±4	LSB

Note 4: The linearity is the deviation of the actual characteristic curve from the expected variation.

#### **Timing Charts**

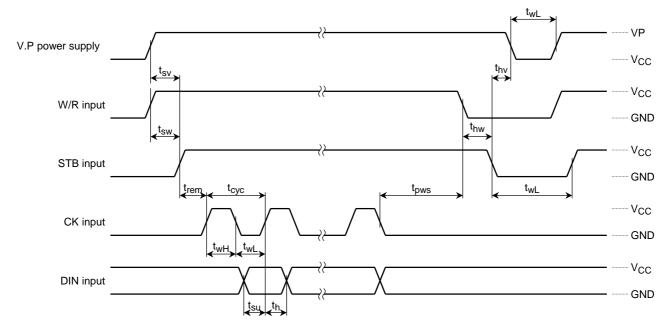


Figure 1 Timing chart for E<sup>2</sup>PROM Write Mode

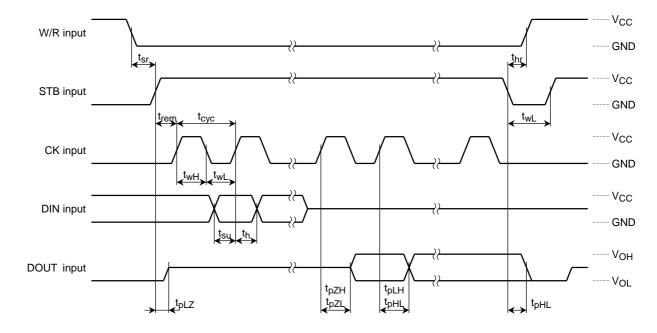


Figure 2 Timing chart for E<sup>2</sup>PROM Read Mode and other operation modes

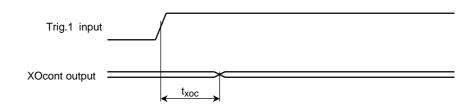
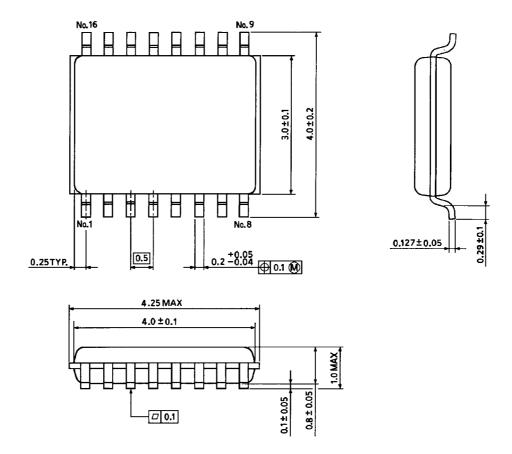


Figure 3 Timing chart for analog output

### **Package Dimensions**



Weight: 0.02 g (typ.)

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000707EBA

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